

**Notice of References Cited**

Application/Control No.

10/568,109

Applicant(s)/Patent Under

Reexamination

ACHIM ET AL.

Examiner

John J. Zimmerman

Art Unit

1775

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,658,488	04-1972	Brown et al.	428/613
*	B	US-3,950,141	04-1976	Roemer, Erich B.	428/643
*	C	US-4,818,628	04-1989	Alexander et al.	428/561
*	D	US-4,832,801	05-1989	Mori, Sanae	205/176
*	E	US-5,328,772 A	07-1994	Tanaka et al.	428/548
*	F	US-5,434,012 A	07-1995	Tanaka et al.	428/643
*	G	US-5,445,896 A	08-1995	Tanaka et al.	428/647
*	H	US-6,309,759 B1	10-2001	Tomikawa et al.	428/642
*	I	US-6,510,726 B1	01-2003	Subramanyan et al.	73/7
*	J	US-2001/0016267	08-2001	Huhn et al.	428/647
*	K	US-2002/0031684	03-2002	Niegel et al.	428/675
*	L	US-2003/0048961	03-2003	Kawachi et al.	384/276
*	M	US-2004/0241489	12-2004	Kawachi et al.	428/642

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	11-050296	02-1999	Japan	Michioka et al.	---
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

*	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.